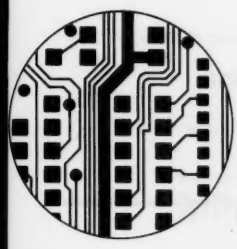

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INTERNATIONAL JOURNAL OF MICROWAVE AND MILLIMETER-WAVE COMPUTER-AIDED ENGINEERING provides a common forum for the dissemination of research and development results in the areas of computer-aided design and engineering of microwave and millimeter-wave components, circuits, subsystems and antennas. The journal is intended to be a single source of valuable information for all engineers and technicians, microwave/mm-wave CAD tool vendors, researchers in industry, government and academia, professors and students, and systems engineers involved in microwave/mm-wave technology.

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